



RADIO TEST REPORT

Test Report No. : 11260540H-A-R1

Applicant : OMRON HEALTHCARE Co., Ltd.
Type of Equipment : Omron BLE Module
Model No. : HHX-MD05T
FCC ID : Q6ZHHXMD05T
Test regulation : FCC Part 15 Subpart C: 2016
Test Result : Complied

1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
7. This report is a revised version of 11260540H-A. 11260540H-A is replaced with this report.

Date of test: May 23 to June 1, 2016

Representative test engineer:

T. Matsui

Tomoki Matsui

Engineer

Consumer Technology Division

Approved by:

Takayuki Shimada

Takayuki Shimada

Engineer

Consumer Technology Division



NVLAP LAB CODE: 200572-0

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13-EM-F0429

REVISION HISTORY

Original Test Report No.: 11260540H-A

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SECTION 1: Customer information

Company Name	:	OMRON HEALTHCARE Co., Ltd.
Address	:	53, Kunotsubo, Terado-cho, Muko, KYOTO, 617-0002 Japan
Telephone Number	:	+81-75-925-2045
Facsimile Number	:	+81-75-925-2046
Contact Person	:	Takefumi Nakanishi

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	Omron BLE Module
Model No.	:	HHX-MD05T
Serial No.	:	Refer to Section 4, Clause 4.2
Rating	:	DC 2.0 V - 3.6 V (Typical : 3.0 V)
Receipt Date of Sample	:	May 23, 2016
Country of Mass-production	:	Japan
Condition of EUT	:	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab

2.2 Product Description

Model: HHX-MD05T (referred to as the EUT in this report) is a Omron BLE Module.

General Specification

Clock frequency(ies) in the system	:	26 MHz
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Radio Specification

Bluetooth Low Energy

Radio Type	:	Transceiver
Frequency of Operation	:	2402 - 2480MHz
Modulation	:	GFSK
Power Supply (radio part input)	:	DC 1.2 V
Antenna type	:	Inverted F-type antenna
Antenna Gain	:	-1.3 dBi

SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC part 15 final revised on April 6, 2016.

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928MHz,
2400-2483.5MHz, and 5725-5850MHz

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 8.8	FCC: Section 15.207 IC: RSS-Gen 8.8	QP 22.3 dB, 26.25900 MHz, L AV 17.1 dB, 26.25900 MHz, L	Complied	-
6dB Bandwidth	FCC: KDB 558074 D01 DTS Meas Guidance v03r05 IC: -	FCC: Section 15.247(a)(2) IC: RSS-247 5.2(1)	See data.	Complied	Conducted
Maximum Peak Output Power	FCC: KDB 558074 D01 DTS Meas Guidance v03r05 IC: RSS-Gen 6.12	FCC: Section 15.247(b)(3) IC: RSS-247 5.4(4)		Complied	Conducted
Power Density	FCC: KDB 558074 D01 DTS Meas Guidance v03r05 IC: -	FCC: Section 15.247(e) IC: RSS-247 5.2(2)		Complied	Conducted
Spurious Emission Restricted Band Edges	FCC: KDB 558074 D01 DTS Meas Guidance v03r05 IC: RSS-Gen 6.13	FCC: Section 15.247(d) IC: RSS-247 5.5 RSS-Gen 8.9 RSS-Gen 8.10	0.1 dB 4880.000 MHz, AV, Vertical.	Complied	Conducted (below 30 MHz)/ Radiated (above 30 MHz) *1)

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.
*1) Radiated test was selected over 30 MHz based on section 15.247(d) and KDB 558074 D01 DTS Meas Guidance v03r05 12.2.7.
* In case any questions arise about test procedure, ANSI C63.10: 2013 is also referred.

FCC Part 15.31 (e)

This EUT provides stable voltage(DC 1.2 V) constantly to RF Module regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

The antenna is not removable from the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 6.6	IC: -	N/A	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

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3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.
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Antenna terminal test Uncertainty (+/-)							
Power meter		Conducted emission and Power density			Conducted emission		Channel power
Below 1 GHz	Above 1 GHz	Below 1 GHz	1 GHz - 3 GHz	3 GHz - 18 GHz	18 GHz - 26.5 GHz	26.5 GHz - 40 GHz	
0.9 dB	1.0 dB	1.4 dB	1.7 dB	2.8 dB	2.8 dB	2.9 dB	

Frequency range	Conducted emission using AMN(LISN) (+dB)
0.009 – 0.15MHz	3.5 dB
0.15 – 30MHz	2.9 dB

Test distance	Radiated emission (+dB) 9 kHz - 30 MHz
3m	3.8 dB
10m	3.7 dB

Polarity	Radiated emission (Below 1GHz)			
	(3 m*)(+dB)		(10 m*)(+dB)	
	30 – 200 MHz	200 – 1000MHz	30 – 200 MHz	200 – 1000MHz
Horizontal	4.9 dB	5.2 dB	4.9 dB	5.0 dB
Vertical	4.6 dB	5.9 dB	5.0 dB	5.0 dB

Radiated emission				
(3 m*)(+dB)		(1 m*)(+dB)	(0.5 m*)(+dB)	(10 m*)(+dB)
1 – 6GHz	6 – 18GHz	10 – 26.5 GHz	26.5 – 40GHz	1 -18 GHz
5.1 dB	5.3 dB	5.1 dB	5.1 dB	5.3 dB

*Measurement distance

Conducted Emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

3.5 Test Location

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Test site	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.6 shielded room	-	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	-	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	-	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	-	3.1 x 5.0 x 2.7	N/A	-	-
No.9 measurement room	-	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	-	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

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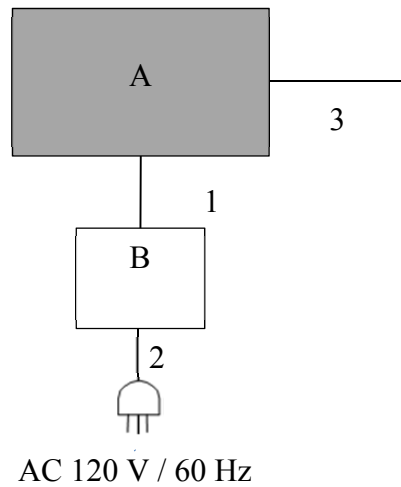
SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

Bluetooth (BT) Low Energy (LE): Transmitting (Tx)

Test Item	Duty cycle *1)	Operating Mode	Tested frequency
Spurious Emission	Worst duty cycle	Tx BT LE Tx	2402 MHz 2440 MHz 2480 MHz
Conducted Emission 6dB Bandwidth Maximum Peak Output Power Power Density 99% Occupied Bandwidth	100 %		
*1) The test was performed with Maximum duty cycle on the actual specification since it used the method that was considered the duty cycle in the measurement result of Spurious Emission. Other than Spurious Emission were performed with 100 % Duty cycle as a test mode. *Power of the EUT was set by the software as follows; Power settings: 0 dBm Software: Serial Command Explorer 2 *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.			

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Omron BLE Module	HHX-MD05T	ES2_19 *1) ES2_40 *2)	OMRON HEALTHCARE Co., Ltd.	EUT
B	DC Power Supply	PMC-35-2A	13090501	KIKUSUI ELECTRONICS CORP.	-

*1) Used for Radiated Emission test and Conducted Emission test

*2) Used for Antenna Terminal conducted test

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Power Cable	5.4 *1) 0.1 *2) 0.5 *3)	Unshielded	Unshielded	-
2	AC Cable	2.2	Unshielded	Unshielded	-
3	Jig Cable	0.1 *4)	Unshielded	Unshielded	-

*1) Used for Radiated Emission test

*2) Used for Conducted Emission test

*3) Used for Antenna Terminal conducted test

*4) Jig Cable does not influence the test result

SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane.

The rear of tabletop was located 40 cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80 cm from a Line Impedance Stabilization Network (LISN) / Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30 cm to 40 cm long and were hanged at a 40 cm height to the ground plane. All unused 50ohm connectors of the LISN (AMN) were resistivity terminated in 50 ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector	: QP and CISPR AV
Measurement range	: 0.15 MHz – 30 MHz
Test data	: APPENDIX
Test result	: Pass

SECTION 6: Radiated Spurious Emission

Test Procedure

It was measured based on "11.0 Emissions in non-restricted frequency bands" of "558074 D01 DTS Meas Guidance v03r05".

[For below 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Biconical	Logperiodic	Horn

In any 100 kHz bandwidth outside the restricted band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

20 dBc was applied to the frequency over the limit of FCC 15.209 / Table 4 of RSS-Gen 8.9(IC) and outside the restricted band of FCC15.205 / Table 6 of RSS-Gen 8.10 (IC).

Frequency	Below 1 GHz	Above 1 GHz		20 dBc
Instrument used	Test Receiver	Spectrum Analyzer		Spectrum Analyzer
Detector	QP	PK	AV	PK
IF Bandwidth	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz	Average Power Method: *3) RBW: 1 MHz VBW: 3 MHz Detector: Power Averaging (RMS) Trace: 100 traces If duty cycle was less than 98%, a duty factor was added to the results. Average Voltage : *4) RBW: 1 MHz VBW : $\geq 1/T$ Detector: Peak Sweep time: auto Trace mode : max hold	RBW: 100 kHz VBW: 300kHz
Test Distance	3 m	4.5 m *1) (1 GHz – 10 GHz), 1 m *2) (10 GHz – 26.5 GHz)		4.5 m *1) (1 GHz – 10 GHz), 1 m *2) (10 GHz – 26.5 GHz)

*1) Distance Factor: $20 \times \log (4.5 \text{ m} / 3.0 \text{ m}) = 3.53 \text{ dB}$

*2) Distance Factor: $20 \times \log (1.0 \text{ m} / 3.0 \text{ m}) = -9.5 \text{ dB}$

*3) Average Power Measurement was performed based on 6. 0 & 12.2.5 of "KDB 558074 D01 DTS Meas Guidance v03r05"

*4) Average Voltage Measurement was performed based on 4.1.4.2.3 of "ANSI C63.10-2013"

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range	: 30 M - 26.5 GHz
Test data	: APPENDIX
Test result	: Pass

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SECTION 7: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
6dB Bandwidth	2 MHz	100 kHz	300 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth *1)	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak/ Average *2)	-	Power Meter (Sensor: 50 MHz BW)
Peak Power Density	1.5 times the 6dB Bandwidth	3 kHz	10 kHz	Auto	Peak	Max Hold	Spectrum Analyzer *3)
Conducted Spurious Emission *4)	9kHz to 150kHz	200 Hz	620 Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150kHz to 30MHz	9.1 kHz	27 kHz				
*1) Peak hold was applied as Worst-case measurement. *2) Reference data *3) Section 10.2 Method PKPSD (peak PSD) of "KDB 558074 D01 DTS Meas Guidance v03r05". *4) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents. Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart. (9 kHz - 150 kHz: RBW = 200 Hz, 150 kHz - 30 MHz: RBW = 9.1 kHz)							

The test results and limit are rounded off to two decimals place, so some differences might be observed.

Test data	: APPENDIX
Test result	: Pass

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APPENDIX 1: Test data

Conducted Emission

DATA OF CONDUCTED EMISSION TEST

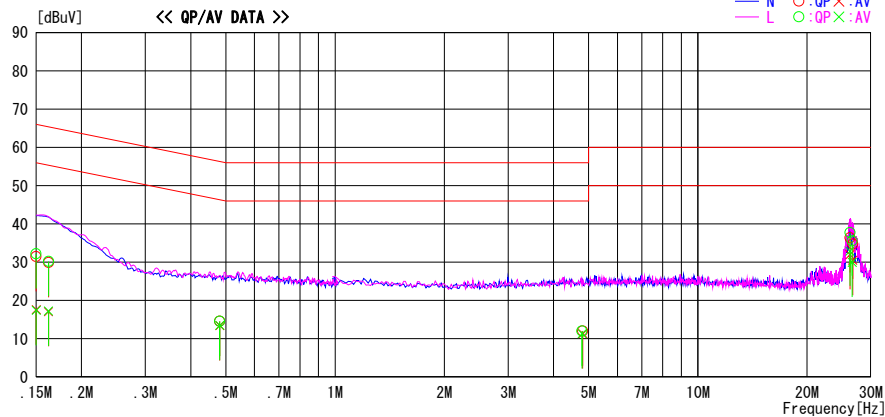
UL Japan, Inc. Ise EMC Lab. No. 4 Semi Anechoic Chamber
Date : 2016/06/01

Report No. : 11260540H

Temp./Humi. : 24 deg. C / 38 % RH
Engineer : Tomoki Matsui

Mode / Remarks : Tx BLE 2402MHz

LIMIT : FCC15.207 QP
FCC15.207 AV



Frequency [MHz]	Reading Level		Corr. Factor	Results		Limit		Margin		Phase	Comment
	QP [dBuV]	AV [dBuV]		QP [dBuV]	AV [dBuV]	QP [dBuV]	AV [dBuV]	QP [dB]	AV [dB]		
0.15000	18.1	4.2	13.4	31.5	17.6	66.0	56.0	34.5	38.4	N	
0.15000	18.8	4.0	13.4	32.2	17.4	66.0	56.0	33.8	38.6	L	
0.16220	16.5	3.7	13.4	29.9	17.1	65.4	55.4	35.5	38.3	N	
0.16220	16.8	3.8	13.4	30.2	17.2	65.4	55.4	35.2	38.2	L	
0.48126	1.2	0.0	13.4	14.6	13.4	56.3	46.3	41.7	32.9	N	
0.48126	1.2	0.1	13.4	14.6	13.5	56.3	46.3	41.7	32.8	L	
4.79704	-1.7	-2.4	13.7	12.0	11.3	56.0	46.0	44.0	34.7	L	
4.81521	-1.7	-2.4	13.7	12.0	11.3	56.0	46.0	44.0	34.7	N	
26.26040	21.5	17.1	14.9	36.4	32.0	60.0	50.0	23.6	18.0	N	
26.25900	22.8	18.0	14.9	37.7	32.9	60.0	50.0	22.3	17.1	L	
26.72930	19.8	15.6	14.9	34.7	30.5	60.0	50.0	25.3	19.5	N	
26.64020	20.7	15.1	14.9	35.6	30.0	60.0	50.0	24.4	20.0	L	

CHART : WITH FACTOR. Peak hold data. CALCULATION : RESULT = READING + C.F (LISN + ATTEN. + CABLE)
Except for the above table : adequate margin data below the limits.

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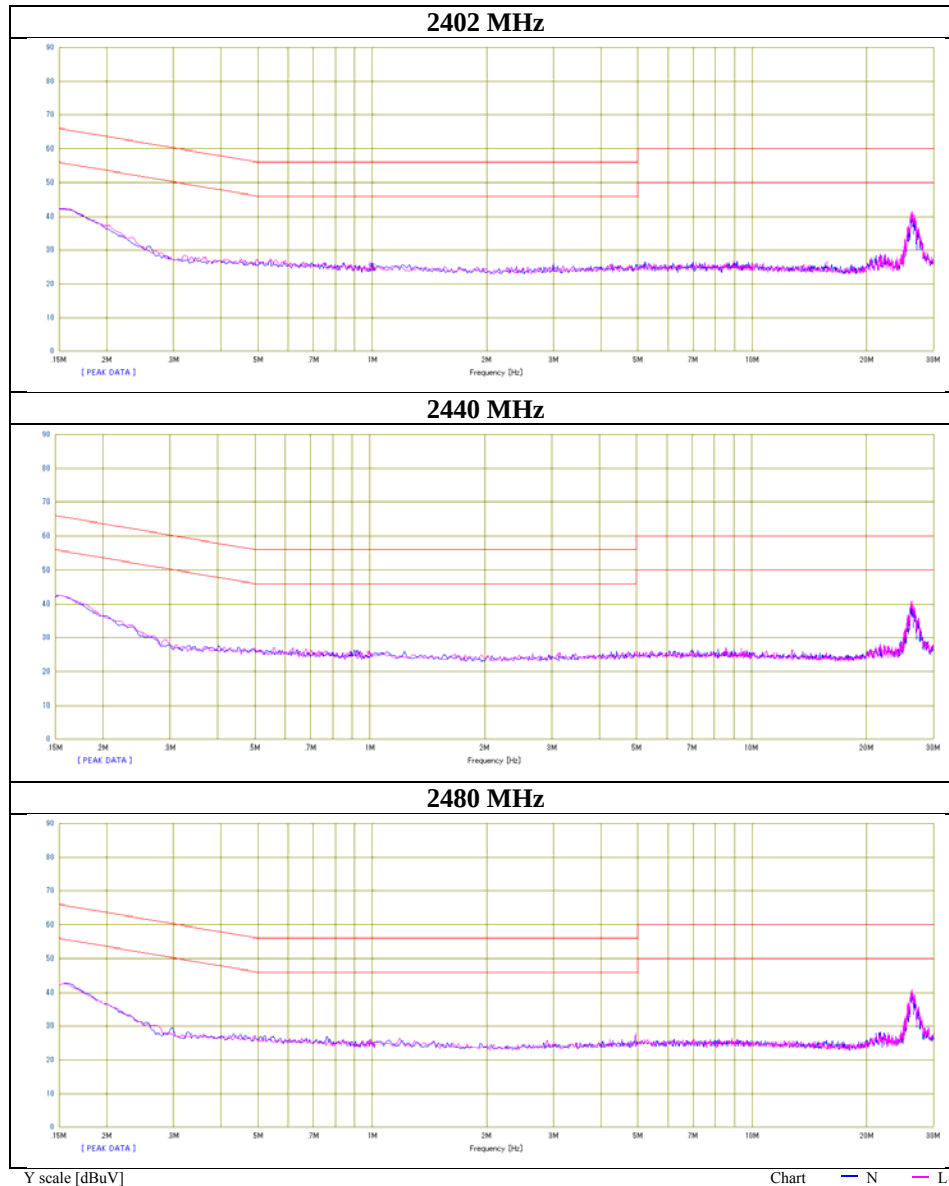
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Conducted Emission

Test place	Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No.	11260540H
Date	June 1, 2016
Temperature / Humidity	24 deg. C / 38 % RH
Engineer	Tomoki Matsui
Mode	Tx BT LE



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6dB Bandwidth

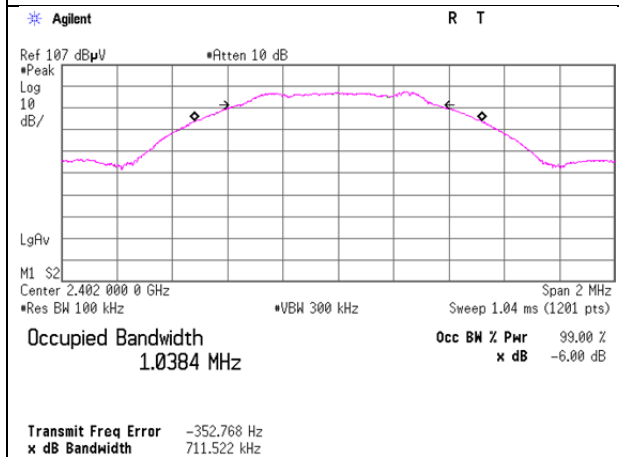
Test place Ise EMC Lab. No.11 Measurement Room
Report No. 11260540H
Date May 23, 2016
Temperature / Humidity 25 deg. C / 46 % RH
Engineer Shinichi Miyazono
Mode Tx BT LE

Mode	Frequency [MHz]	6dB Bandwidth [MHz]	Limit [kHz]
BT LE	2402	0.712	> 500
	2440	0.714	> 500
	2480	0.715	> 500

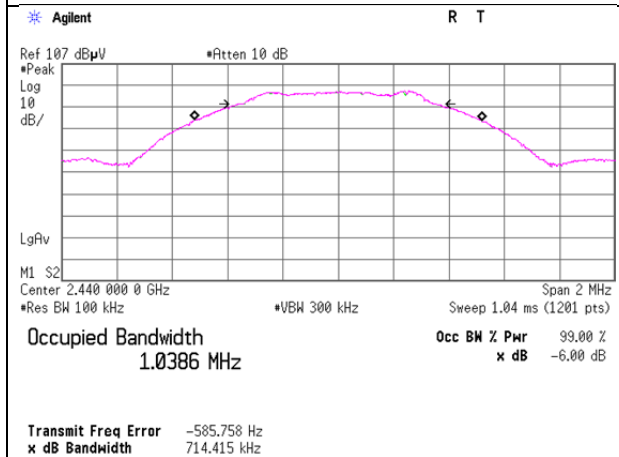
6dB Bandwidth

BT LE

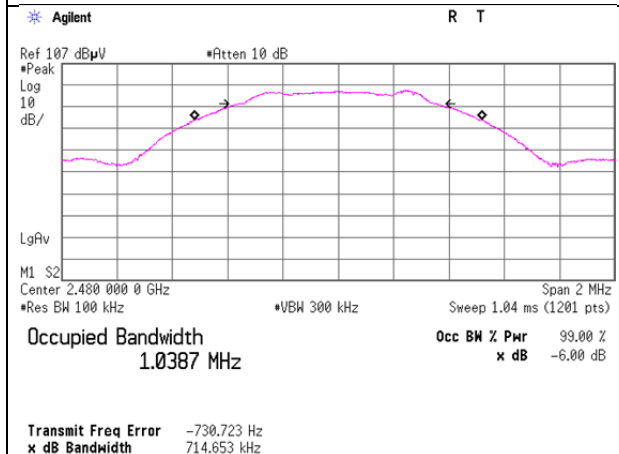
2402 MHz



2440 MHz



2480 MHz



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Maximum Peak Output Power

Test place : Ise EMC Lab. No.11 Measurement Room
Report No. : 11260540H
Date : May 23, 2016
Temperature / Humidity : 25 deg. C / 46 % RH
Engineer : Shinichi Miyazono
Mode : Tx BT LE

BT LE

Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
				[dBm]	[mW]	[dBm]	[mW]	
2402	-11.83	1.46	10.08	-0.29	0.94	30.00	1000	30.29
2440	-11.85	1.47	10.08	-0.30	0.93	30.00	1000	30.30
2480	-11.81	1.48	10.08	-0.25	0.94	30.00	1000	30.25

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator Loss

Average Output Power
(Reference data for RF Exposure / SAR testing)

Test place : Ise EMC Lab. No.11 Measurement Room
Report No. : 11260540H
Date : May 23, 2016
Temperature / Humidity : 25 deg. C / 46 % RH
Engineer : Shinichi Miyazono
Mode : Tx BT LE

BT LE

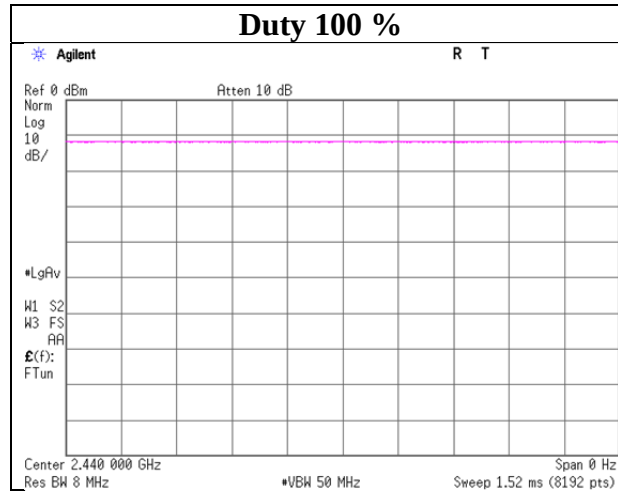
Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result (Burst power average)	
				[dBm]	[mW]
2402	-12.09	1.46	10.08	-0.55	0.88
2440	-12.13	1.47	10.08	-0.58	0.87
2480	-12.09	1.48	10.08	-0.53	0.89

Sample Calculation:

Result (Burst power average) = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator

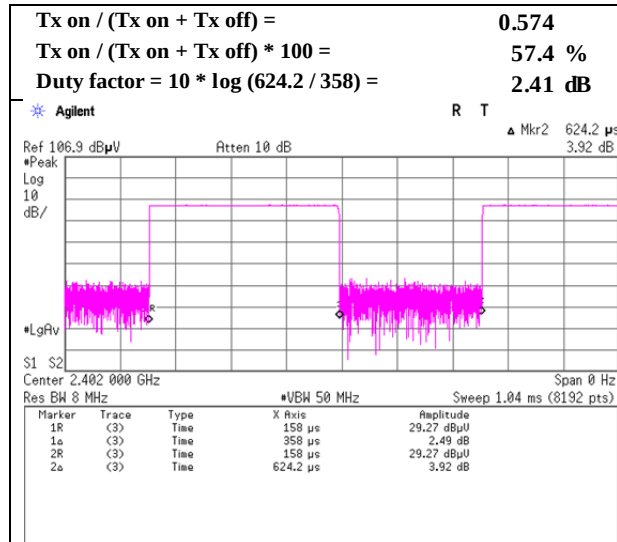
Burst rate confirmation
(Antenna Terminal Test)

Test place Ise EMC Lab. No.11 Measurement Room
Report No. 11260540H
Date May 23, 2016
Temperature / Humidity 25 deg. C / 46 % RH
Engineer Shinichi Miyazono
Mode Tx BT LE



Burst rate confirmation
(Radiated Spurious Emission Test)

Test place Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No. 11260540H
Date May 31, 2016
Temperature / Humidity 23 deg. C / 63 % RH
Engineer Tomoki Matsui
Mode Tx BT LE



Radiated Spurious Emission

Test place	Ise EMC Lab.		
Report No.	11260540H		
Semi Anechoic Chamber	No.3	No.4	No.4
Date	May 24, 2016	May 31, 2016	June 1, 2016
Temperature / Humidity	25 deg. C / 40 % RH	23 deg. C / 63 % RH	24 deg. C / 52 % RH
Engineer	Takafumi Noguchi	Tomoki Matsui	Shinichi Miyazono
	(Below 1 GHz)	(1 GHz - 10 GHz)	(10 GHz - 26.5 GHz)
Mode	Tx BT LE 2402 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	37.700	QP	22.5	15.0	7.1	32.2	-	12.4	40.0	27.6	
Hori	74.000	QP	22.6	6.3	7.7	32.2	-	4.4	40.0	35.6	
Hori	75.000	QP	22.5	6.3	7.7	32.2	-	4.3	40.0	35.7	
Hori	200.000	QP	22.1	11.4	9.0	32.1	-	10.4	43.5	33.1	
Hori	300.000	QP	22.2	13.5	9.8	31.9	-	13.6	46.0	32.4	
Hori	400.000	QP	22.0	15.6	10.5	31.9	-	16.2	46.0	29.8	
Hori	2388.922	PK	49.1	27.9	6.8	32.1	-	51.7	73.9	22.2	
Hori	2390.000	PK	44.0	27.9	6.8	32.1	-	46.6	73.9	27.3	
Hori	4804.000	PK	53.6	32.8	9.2	37.1	-	58.5	73.9	15.4	X-Axis
Hori	7206.000	PK	47.9	36.8	10.4	37.8	-	57.3	73.9	16.6	
Hori	9608.000	PK	44.8	38.1	11.1	39.1	-	54.9	73.9	19.0	
Hori	12010.000	PK	48.2	39.9	-1.1	33.2	-	53.8	73.9	20.1	
Hori	14412.000	PK	45.7	41.4	0.2	32.6	-	54.7	73.9	19.2	
Hori	2388.922	AV	34.9	27.9	6.8	32.1	2.4	39.9	53.9	14.0	
Hori	2390.000	AV	32.7	27.9	6.8	32.1	2.4	37.7	53.9	16.2	*1)
Hori	4804.000	AV	48.7	32.8	9.2	37.1	-	53.6	53.9	0.3	X-Axis *2)
Hori	7206.000	AV	38.7	36.8	10.4	37.8	2.4	50.5	53.9	3.4	
Hori	9608.000	AV	36.5	38.1	11.1	39.1	2.4	49.0	53.9	4.9	
Hori	12010.000	AV	41.6	39.9	-1.1	33.2	2.4	49.6	53.9	4.3	
Hori	14412.000	AV	38.1	41.4	0.2	32.6	2.4	49.5	53.9	4.4	
Vert	37.700	QP	22.6	15.0	7.1	32.2	-	12.5	40.0	27.5	
Vert	74.000	QP	22.7	6.3	7.7	32.2	-	4.5	40.0	35.5	
Vert	75.000	QP	22.7	6.3	7.7	32.2	-	4.5	40.0	35.5	
Vert	200.000	QP	22.2	11.4	9.0	32.1	-	10.5	43.5	33.0	
Vert	300.000	QP	22.1	13.5	9.8	31.9	-	13.5	46.0	32.5	
Vert	400.000	QP	22.1	15.6	10.5	31.9	-	16.3	46.0	29.7	
Vert	2388.958	PK	48.8	27.9	6.8	32.1	-	51.4	73.9	22.5	
Vert	2390.000	PK	43.8	27.9	6.8	32.1	-	46.4	73.9	27.5	
Vert	4804.000	PK	52.4	32.8	9.2	37.1	-	57.3	73.9	16.6	Y-Axis
Vert	7206.000	PK	46.1	36.8	10.4	37.8	-	55.5	73.9	18.4	
Vert	9608.000	PK	45.7	38.1	11.1	39.1	-	55.8	73.9	18.1	
Vert	12010.000	PK	47.4	39.9	-1.1	33.2	-	53.0	73.9	20.9	Y-Axis
Vert	14412.000	PK	47.0	41.4	0.2	32.6	-	56.0	73.9	17.9	Y-Axis
Vert	2388.958	AV	35.1	27.9	6.8	32.1	2.4	40.1	53.9	13.8	
Vert	2390.000	AV	33.8	27.9	6.8	32.1	2.4	38.8	53.9	15.1	*1)
Vert	4804.000	AV	47.1	32.8	9.2	37.1	-	52.0	53.9	1.9	Y-Axis *2)
Vert	7206.000	AV	37.8	36.8	10.4	37.8	2.4	49.6	53.9	4.3	
Vert	9608.000	AV	36.8	38.1	11.1	39.1	2.4	49.3	53.9	4.6	
Vert	12010.000	AV	39.3	39.9	-1.1	33.2	2.4	47.3	53.9	6.6	Y-Axis
Vert	14412.000	AV	40.2	41.4	0.2	32.6	2.4	51.6	53.9	2.3	Y-Axis

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)+Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (4.5m / 3.0 m) = 3.53 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

*1) Not Out of Band emission(Leakage Power)

*2) It used Average Voltage Measurement.

20dBc Data Sheet

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	2402.000	PK	89.9	28.0	6.8	32.1	92.6	-	-	Carrier
Hori	2400.000	PK	44.4	28.0	6.8	32.1	47.1	72.6	25.5	
Vert	2402.000	PK	88.8	28.0	6.8	32.1	91.5	-	-	Carrier
Vert	2400.000	PK	43.6	28.0	6.8	32.1	46.3	71.5	25.2	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)

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Ise EMC Lab.

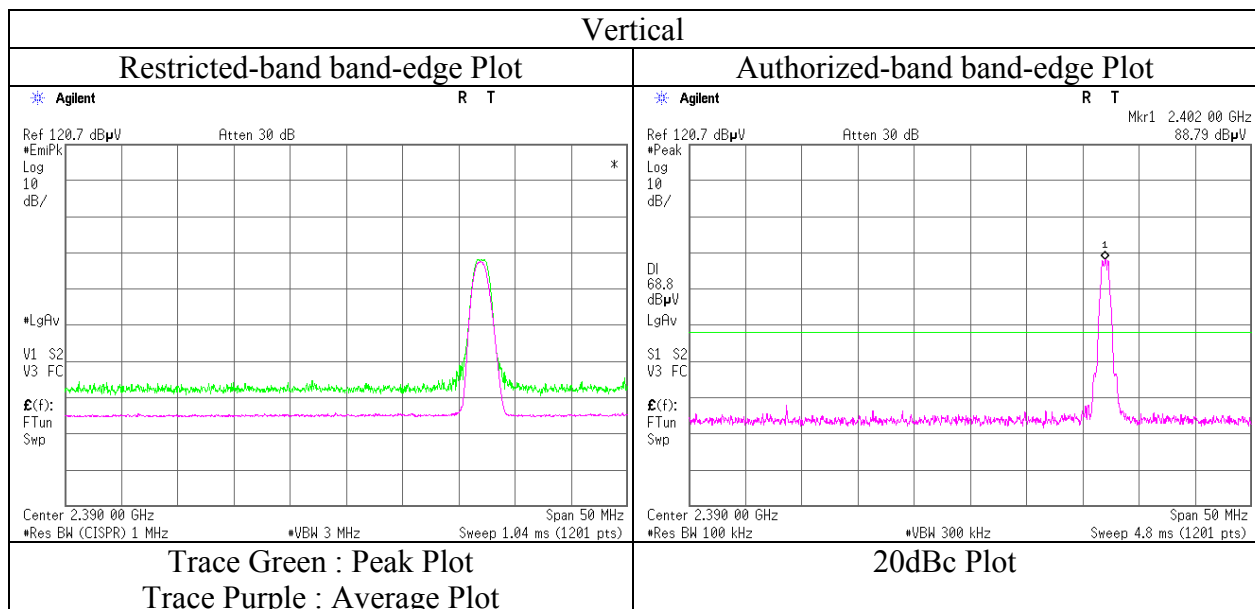
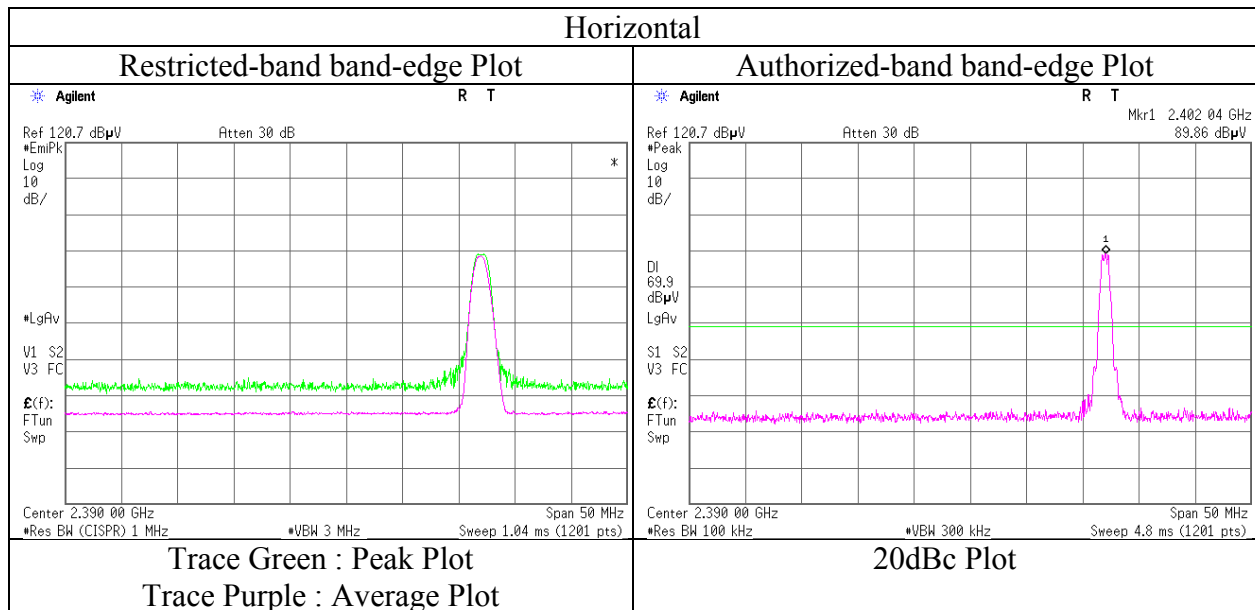
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Telephone : +81 596 24 8999

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Radiated Spurious Emission (Reference Plot for band-edge)

Test place	Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No.	11260540H
Date	May 31, 2016
Temperature / Humidity	23 deg. C / 63 % RH
Engineer	Tomoki Matsui
	(1 GHz - 10 GHz)
Mode	Tx BT LE 2402 MHz



* Final result of restricted band edge was shown in tabular data.

UL Japan, Inc.

Ise EMC Lab.

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Radiated Spurious Emission

Test place	Ise EMC Lab.		
Report No.	11260540H		
Semi Anechoic Chamber	No.3	No.4	No.4
Date	May 24, 2016	May 31, 2016	June 1, 2016
Temperature / Humidity	25 deg. C / 40 % RH	23 deg. C / 63 % RH	24 deg. C / 52 % RH
Engineer	Takafumi Noguchi (Below 1 GHz)	Tomoki Matsui (1 GHz - 10 GHz)	Shinichi Miyazono (10 GHz - 26.5 GHz)
Mode	Tx BT LE 2440 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	37.700	QP	22.6	15.0	7.1	32.2	-	12.5	40.0	27.5	
Hori	74.000	QP	22.6	6.3	7.7	32.2	-	4.4	40.0	35.6	
Hori	75.000	QP	22.5	6.3	7.7	32.2	-	4.3	40.0	35.7	
Hori	200.000	QP	22.2	11.4	9.0	32.1	-	10.5	43.5	33.0	
Hori	300.000	QP	22.2	13.5	9.8	31.9	-	13.6	46.0	32.4	
Hori	400.000	QP	22.0	15.6	10.5	31.9	-	16.2	46.0	29.8	
Hori	4880.000	PK	51.4	33.1	9.3	37.2	-	56.6	73.9	17.3	Floor Noise
Hori	7320.000	PK	46.0	36.8	10.4	37.9	-	55.3	73.9	18.6	
Hori	9760.000	PK	44.7	38.2	11.2	39.2	-	54.9	73.9	19.0	
Hori	12200.000	PK	48.2	39.9	-1.0	33.0	-	54.1	73.9	19.8	
Hori	14640.000	PK	47.0	41.4	0.4	32.6	-	56.2	73.9	17.7	
Hori	4880.000	AV	46.0	33.1	9.3	37.2	2.4	53.6	53.9	0.3	Floor Noise
Hori	7320.000	AV	37.6	36.8	10.4	37.9	2.4	49.3	53.9	4.6	
Hori	9760.000	AV	35.0	38.2	11.2	39.2	-	45.2	53.9	8.7	
Hori	12200.000	AV	41.7	39.9	-1.0	33.0	2.4	50.0	53.9	3.9	
Hori	14640.000	AV	39.2	41.4	0.4	32.6	2.4	50.8	53.9	3.1	
Vert	37.700	QP	22.6	15.0	7.1	32.2	-	12.5	40.0	27.5	
Vert	74.000	QP	22.7	6.3	7.7	32.2	-	4.5	40.0	35.5	
Vert	75.000	QP	22.7	6.3	7.7	32.2	-	4.5	40.0	35.5	
Vert	200.000	QP	22.2	11.4	9.0	32.1	-	10.5	43.5	33.0	
Vert	300.000	QP	22.2	13.5	9.8	31.9	-	13.6	46.0	32.4	
Vert	400.000	QP	22.0	15.6	10.5	31.9	-	16.2	46.0	29.8	
Vert	4880.000	PK	51.4	33.1	9.3	37.2	-	56.6	73.9	17.3	Y-Axis
Vert	7320.000	PK	46.4	36.8	10.4	37.9	-	55.7	73.9	18.2	
Vert	9760.000	PK	44.0	38.2	11.2	39.2	-	54.2	73.9	19.7	
Vert	12200.000	PK	49.6	39.9	-1.0	33.0	-	55.5	73.9	18.4	
Vert	14640.000	PK	47.5	41.4	0.4	32.6	-	56.7	73.9	17.2	
Vert	4880.000	AV	46.2	33.1	9.3	37.2	2.4	53.8	53.9	0.1	Y-Axis
Vert	7320.000	AV	38.4	36.8	10.4	37.9	2.4	50.1	53.9	3.8	
Vert	9760.000	AV	34.7	38.2	11.2	39.2	-	44.9	53.9	9.0	
Vert	12200.000	AV	43.0	39.9	-1.0	33.0	2.4	51.3	53.9	2.6	
Vert	14640.000	AV	40.6	41.4	0.4	32.6	2.4	52.2	53.9	1.7	

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)+Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (4.5m / 3.0 m) = 3.53 dB
10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

*1) Not Out of Band emission(Leakage Power)

Radiated Spurious Emission

Test place	Ise EMC Lab.		
Report No.	11260540H		
Semi Anechoic Chamber	No.3	No.4	No.4
Date	May 24, 2016	May 31, 2016	June 1, 2016
Temperature / Humidity	25 deg. C / 40 % RH	23 deg. C / 63 % RH	24 deg. C / 52 % RH
Engineer	Takafumi Noguchi (Below 1 GHz)	Tomoki Matsui (1 GHz - 10 GHz)	Shinichi Miyazono (10 GHz - 26.5 GHz)
Mode	Tx BT LE 2480 MHz		

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	37.700	QP	22.6	15.0	7.1	32.2	-	12.5	40.0	27.5	
Hori	74.000	QP	22.5	6.3	7.7	32.2	-	4.3	40.0	35.7	
Hori	75.000	QP	22.5	6.3	7.7	32.2	-	4.3	40.0	35.7	
Hori	200.000	QP	22.2	11.4	9.0	32.1	-	10.5	43.5	33.0	
Hori	300.000	QP	22.1	13.5	9.8	31.9	-	13.5	46.0	32.5	
Hori	400.000	QP	22.0	15.6	10.5	31.9	-	16.2	46.0	29.8	
Hori	2483.500	PK	50.4	28.1	6.9	32.1	-	53.3	73.9	20.6	
Hori	2492.692	PK	53.2	28.1	6.9	32.1	-	56.1	73.9	17.8	
Hori	4960.000	PK	47.4	33.4	9.3	37.2	-	52.9	73.9	21.0	X-Axis
Hori	7440.000	PK	47.6	36.8	10.4	38.0	-	56.8	73.9	17.1	
Hori	9920.000	PK	44.5	38.3	11.2	39.3	-	54.7	73.9	19.2	Floor Noise
Hori	12400.000	PK	46.5	39.8	-0.9	32.9	-	52.5	73.9	21.4	
Hori	14880.000	PK	45.6	41.4	0.7	32.6	-	55.1	73.9	18.8	
Hori	2483.500	AV	36.6	28.1	6.9	32.1	2.4	41.9	53.9	12.0	*1)
Hori	2492.692	AV	38.2	28.1	6.9	32.1	2.4	43.5	53.9	10.4	
Hori	4960.000	AV	40.1	33.4	9.3	37.2	2.4	48.0	53.9	5.9	X-Axis
Hori	7440.000	AV	40.2	36.8	10.4	38.0	2.4	51.8	53.9	2.1	
Hori	9920.000	AV	35.8	38.3	11.2	39.3	-	46.0	53.9	7.9	Floor Noise
Hori	12400.000	AV	39.0	39.8	-0.9	32.9	2.4	47.4	53.9	6.5	
Hori	14880.000	AV	37.9	41.4	0.7	32.6	2.4	49.8	53.9	4.1	
Vert	37.700	QP	22.6	15.0	7.1	32.2	-	12.5	40.0	27.5	
Vert	74.000	QP	22.7	6.3	7.7	32.2	-	4.5	40.0	35.5	
Vert	75.000	QP	22.7	6.3	7.7	32.2	-	4.5	40.0	35.5	
Vert	200.000	QP	22.2	11.4	9.0	32.1	-	10.5	43.5	33.0	
Vert	300.000	QP	22.1	13.5	9.8	31.9	-	13.5	46.0	32.5	
Vert	400.000	QP	22.1	15.6	10.5	31.9	-	16.3	46.0	29.7	
Vert	2483.500	PK	50.0	28.1	6.9	37.0	-	48.0	73.9	25.9	
Vert	2492.745	PK	52.0	28.1	6.9	37.0	-	50.0	73.9	23.9	
Vert	4960.000	PK	48.2	33.4	9.3	37.2	-	53.7	73.9	20.2	Y-Axis
Vert	7440.000	PK	47.4	36.8	10.4	38.0	-	56.6	73.9	17.3	
Vert	9920.000	PK	44.6	38.3	11.2	39.3	-	54.8	73.9	19.1	Floor Noise
Vert	12400.000	PK	47.1	39.8	-0.9	32.9	-	53.1	73.9	20.8	Y-Axis
Vert	14880.000	PK	45.8	41.4	0.7	32.6	-	55.3	73.9	18.6	Y-Axis
Vert	2483.500	AV	36.1	28.1	6.9	37.0	2.4	36.5	53.9	17.4	*1)
Vert	2492.745	AV	38.3	28.1	6.9	37.0	2.4	38.7	53.9	15.2	
Vert	4960.000	AV	41.7	33.4	9.3	37.2	2.4	49.6	53.9	4.3	Y-Axis
Vert	7440.000	AV	39.9	36.8	10.4	38.0	2.4	51.5	53.9	2.4	
Vert	9920.000	AV	35.9	38.3	11.2	39.3	-	46.1	53.9	7.8	Floor Noise
Vert	12400.000	AV	40.5	39.8	-0.9	32.9	2.4	48.9	53.9	5.0	Y-Axis
Vert	14880.000	AV	38.7	41.4	0.7	32.6	2.4	50.6	53.9	3.3	Y-Axis

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance factor(above 1 GHz)) - Gain(Amplifier)+Duty factor

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

Distance factor: 1 GHz - 10 GHz 20log (4.5m / 3.0 m) = 3.53 dB

10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB

*1) Not Out of Band emission(Leakage Power)

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Ise EMC Lab.

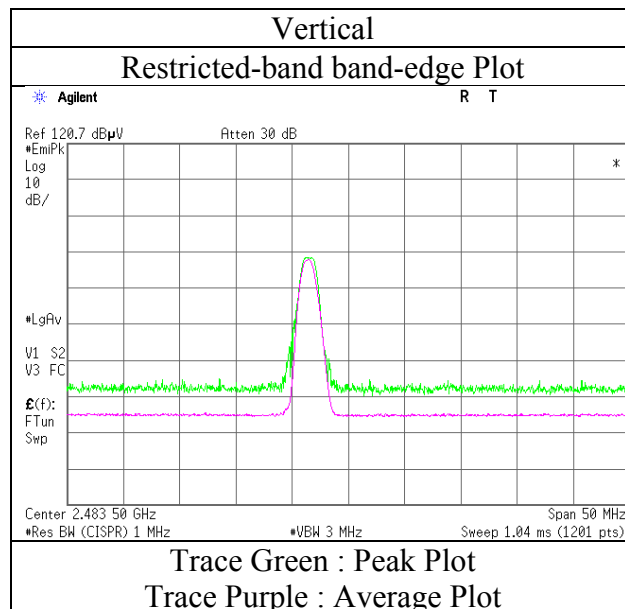
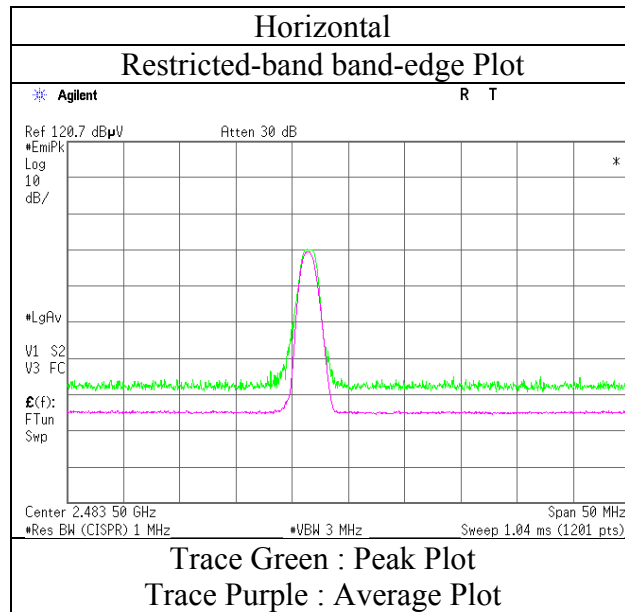
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Radiated Spurious Emission
(Reference Plot for band-edge)

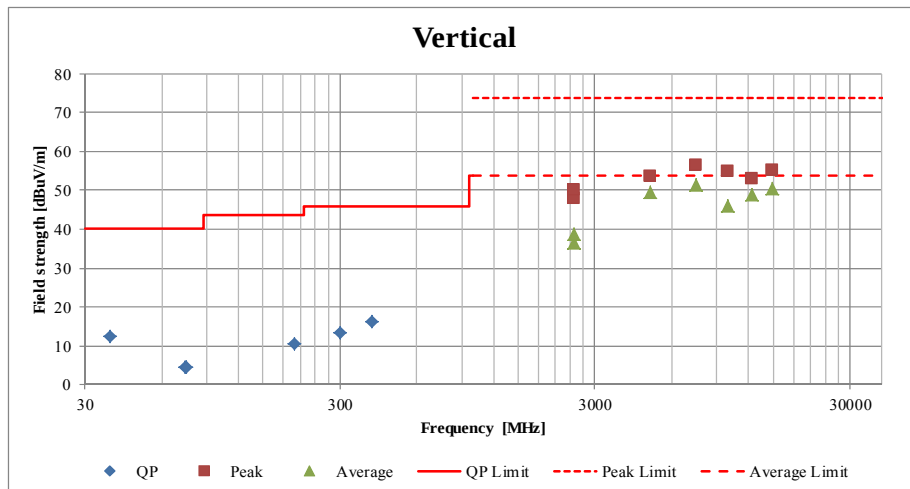
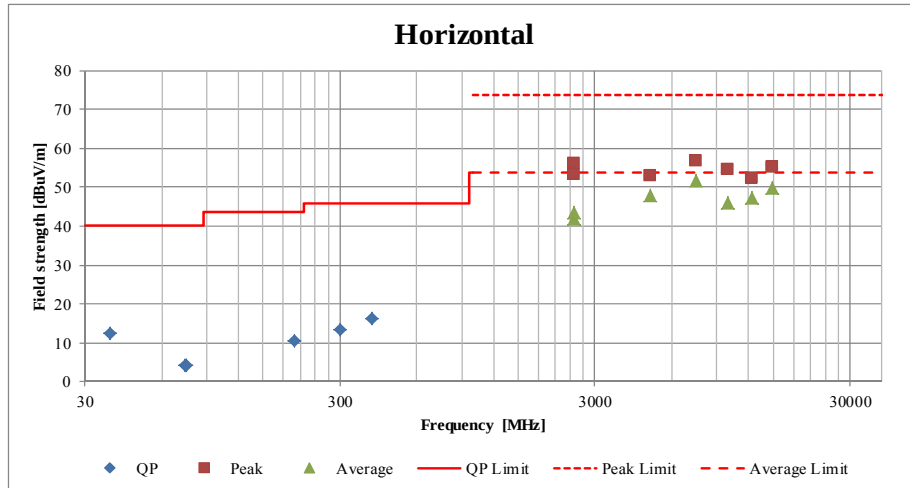
Test place : Ise EMC Lab. No.4 Semi Anechoic Chamber
Report No. : 11260540H
Date : May 31, 2016
Temperature / Humidity : 23 deg. C / 63 % RH
Engineer : Tomoki Matsui
(1 GHz - 10 GHz)
Mode : Tx BT LE 2480 MHz



* Final result of restricted band edge was shown in tabular data.

Radiated Spurious Emission (Plot data, Worst case)

Test place	Ise EMC Lab.		
Report No.	11260540H		
Semi Anechoic Chamber	No.3	No.4	No.4
Date	May 24, 2016	May 31, 2016	June 1, 2016
Temperature / Humidity	25 deg. C / 40 % RH	23 deg. C / 63 % RH	24 deg. C / 52 % RH
Engineer	Takafumi Noguchi (Below 1 GHz)	Tomoki Matsui (1 GHz - 10 GHz)	Shinichi Miyazono (10 GHz - 26.5 GHz)
Mode	Tx BT LE 2480 MHz		



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

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Ise EMC Lab.

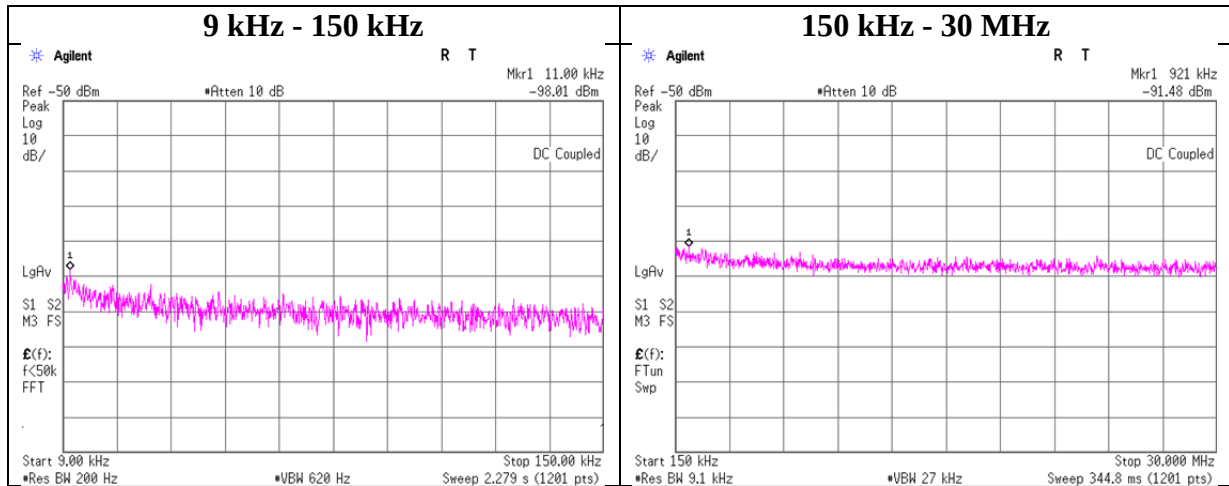
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Conducted Spurious Emission

Test place : Ise EMC Lab. No.11 Measurement Room
Report No. : 11260540H
Date : May 23, 2016
Temperature / Humidity : 25 deg. C / 46 % RH
Engineer : Shinichi Miyazono
Mode : Tx BT LE 2402 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
11.00	-98.0	0.10	9.8	2.0	1	-86.1	300	6.0	-24.8	46.7	71.5	
921.00	-91.5	0.11	9.9	2.0	1	-79.5	30	6.0	1.8	28.3	26.5	

$E = \text{EIRP} - 20 \log(D) + \text{Ground bounce} + 104.8 \text{ [dBuV/m]}$

$\text{EIRP} = \text{Reading} + \text{Cable Loss} + \text{Attenuator Loss} + \text{Antenna Gain} + 10 * \log(N)$

UL Japan, Inc.

Ise EMC Lab.

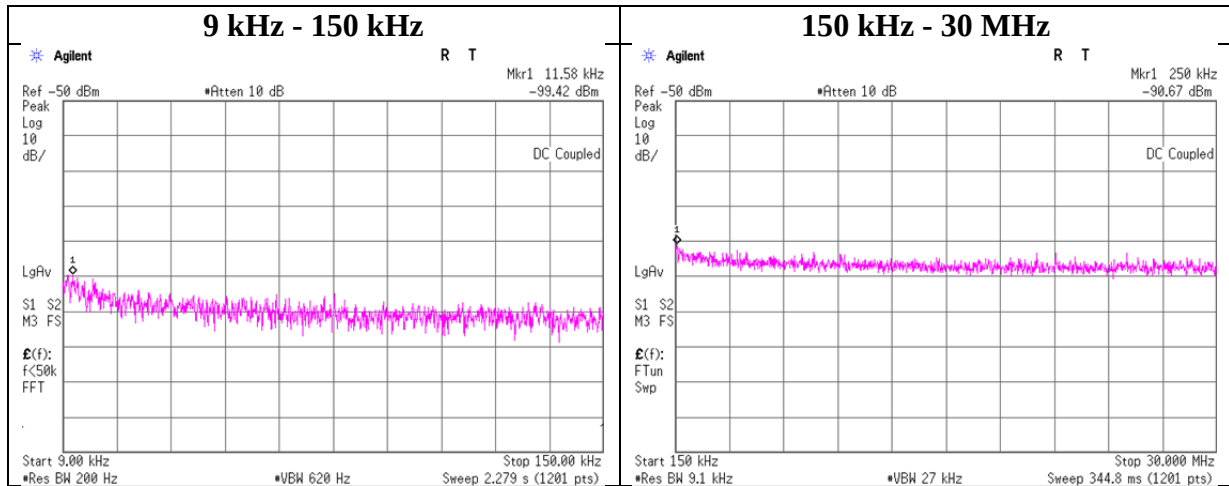
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Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

Conducted Spurious Emission

Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11260540H
Date	May 23, 2016
Temperature / Humidity	25 deg. C / 46 % RH
Engineer	Shinichi Miyazono
Mode	Tx BT LE 2440 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
11.58	-99.4	0.10	9.8	2.0	1	-87.5	300	6.0	-26.2	46.3	72.5	
250.00	-90.7	0.11	9.9	2.0	1	-78.7	300	6.0	-17.5	19.6	37.1	

$E = \text{EIRP} - 20 \log(D) + \text{Ground bounce} + 104.8 \text{ [dBuV/m]}$

$\text{EIRP} = \text{Reading} + \text{Cable Loss} + \text{Attenuator Loss} + \text{Antenna Gain} + 10 * \log(N)$

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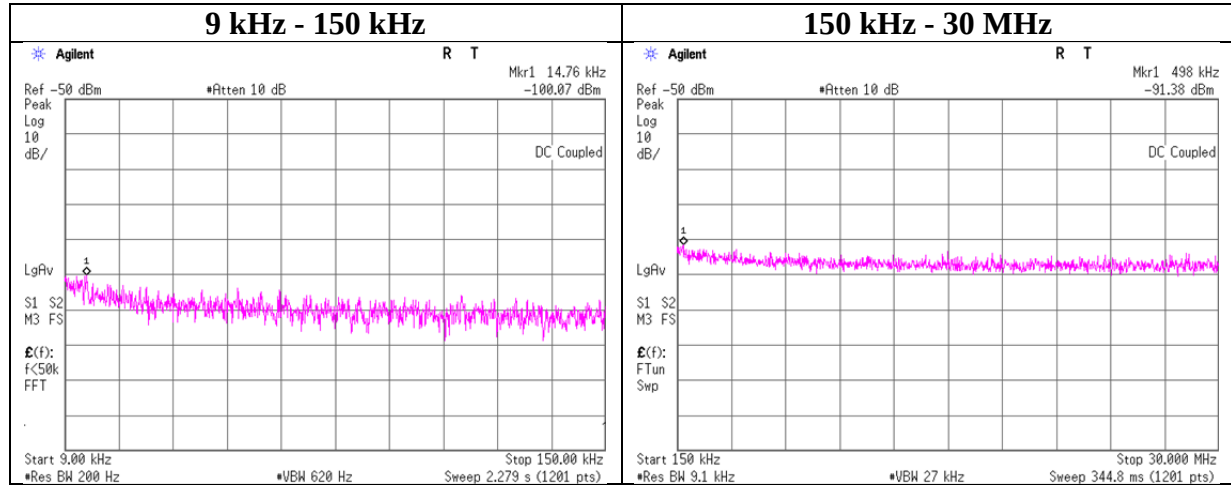
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Conducted Spurious Emission

Test place	Ise EMC Lab. No.11 Measurement Room
Report No.	11260540H
Date	May 23, 2016
Temperature / Humidity	25 deg. C / 46 % RH
Engineer	Shinichi Miyazono
Mode	Tx BT LE 2480 MHz



Frequency [kHz]	Reading [dBm]	Cable Loss [dB]	Attenuator Loss [dB]	Antenna Gain [dBi]	N (Number of Output)	EIRP [dBm]	Distance [m]	Ground bounce [dB]	E (field strength) [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
14.76	-100.1	0.10	9.8	2.0	1	-88.2	300	6.0	-26.9	44.2	71.1	
498.00	-91.4	0.11	9.9	2.0	1	-79.4	30	6.0	1.9	33.6	31.7	

$E = \text{EIRP} - 20 \log(D) + \text{Ground bounce} + 104.8 \text{ [dBuV/m]}$

$\text{EIRP} = \text{Reading} + \text{Cable Loss} + \text{Attenuator Loss} + \text{Antenna Gain} + 10 * \log(N)$

Power Density

Test place : Ise EMC Lab. No.11 Measurement Room
Report No. : 11260540H
Date : May 23, 2016
Temperature / Humidity : 25 deg. C / 46 % RH
Engineer : Shinichi Miyazono
Mode : Tx BT LE

BT LE

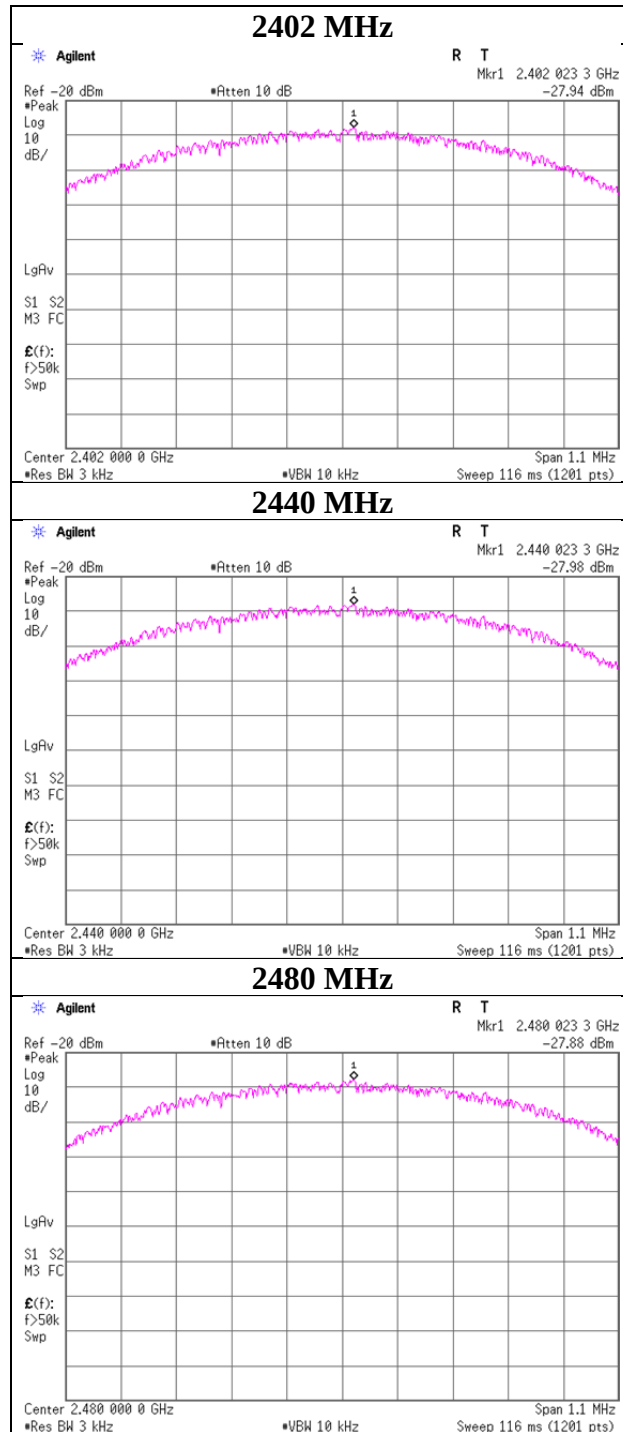
Freq. [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
2402.00	-27.94	1.46	10.08	-16.40	8.00	24.40
2440.00	-27.98	1.47	10.08	-16.43	8.00	24.43
2480.00	-27.88	1.48	10.08	-16.32	8.00	24.32

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Attenuator

Power Density

BT LE



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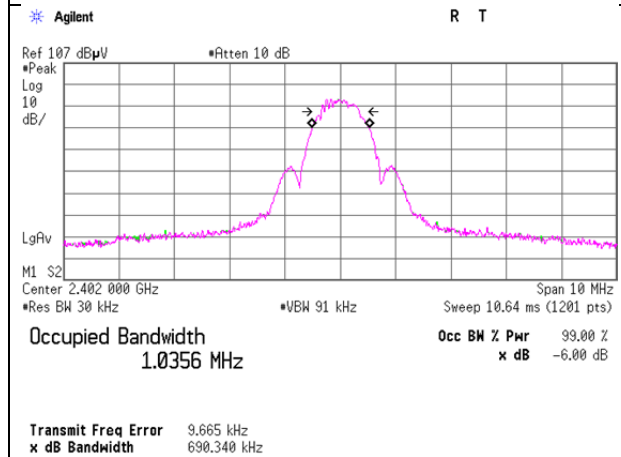
Facsimile : +81 596 24 8124

99%Occupied Bandwidth

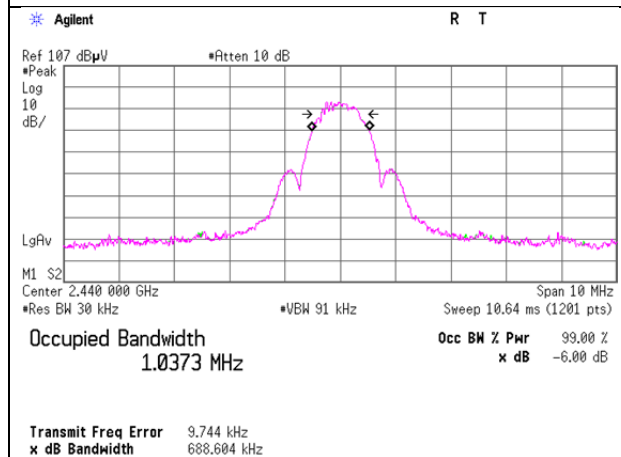
Test place Ise EMC Lab. No.11 Measurement Room
Report No. 11260540H
Date May 23, 2016
Temperature / Humidity 25 deg. C / 46 % RH
Engineer Shinichi Miyazono
Mode Tx BT LE

BT LE

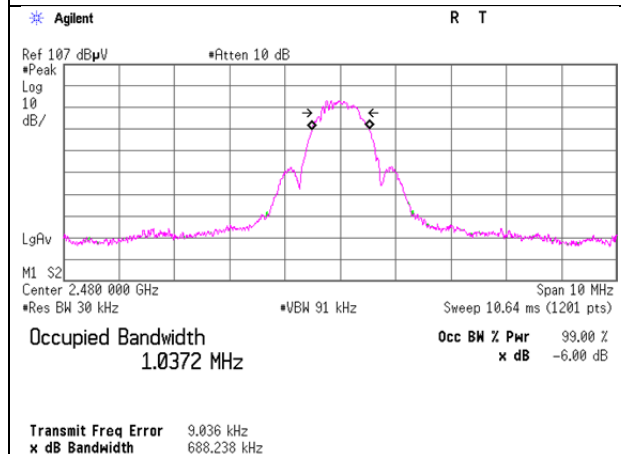
2402 MHz



2440 MHz



2480 MHz



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APPENDIX 2: Test instruments

Test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MRENT-126	Spectrum Analyzer	KEYSIGHT	E4440A	MY46185516	AT	2015/07/31 * 12
MPM-08	Power Meter	Anritsu	ML2495A	6K00003338	AT	2015/10/08 * 12
MPSE-11	Power sensor	Anritsu	MA2411B	011737	AT	2015/10/08 * 12
MCC-137	Microwave cable	HUBER+SUHNER	SUCOFLEX 102	37954/2	AT	2015/10/08 * 12
MAT-20	Attenuator(10dB)(above 1GHz)	HIROSE ELECTRIC CO.,LTD.	AT-110	-	AT	2016/01/08 * 12
MCC-38	Coaxial Cable	UL Japan	-	-	AT	2015/12/07 * 12
MAT-10	Attenuator(10dB)	Weinschel Corp	2	BL1173	AT	2015/11/10 * 12
MMM-07	DIGITAL HiTESTER	Hioki	3805	051201150	AT	2016/01/18 * 12
MOS-19	Thermo-Hygrometer	Custom	CTH-201	0001	AT	2015/12/08 * 12
MAEC-03	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2015/10/01 * 12
MOS-13	Thermo-Hygrometer	Custom	CTH-180	1301	RE	2016/01/21 * 12
MJM-16	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE/CE	-
MSA-10	Spectrum Analyzer	Agilent	E4448A	MY46180655	RE	2016/02/24 * 12
MTR-08	Test Receiver	Rohde & Schwarz	ESCI	100767	RE	2015/09/02 * 12
MBA-05	Biconical Antenna	Schwarzbeck	BBA9106	1302	RE	2015/11/02 * 12
MLA-22	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-191	RE	2016/01/30 * 12
MCC-51	Coaxial cable	UL Japan	-	-	RE	2015/07/13 * 12
MAT-70	Attenuator(6dB)	Agilent	8491A-006	MY52460153	RE	2016/04/05 * 12
MPA-13	Pre Amplifier	SONOMA INSTRUMENT	310	260834	RE	2016/03/24 * 12
MMM-08	DIGITAL HiTESTER	Hioki	3805	051201197	RE	2016/01/13 * 12
MAEC-04	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE/CE	2015/10/02 * 12
MOS-15	Thermo-Hygrometer	Custom	CTH-180	1501	RE/CE	2016/01/21 * 12
MJM-26	Measure	KOMELON	KMC-36	-	RE/CE	-
MSA-03	Spectrum Analyzer	Agilent	E4448A	MY44020357	RE	2016/05/19 * 12
MHA-21	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	RE	2015/08/10 * 12
MCC-141	Microwave Cable	Junkosha	MWX221	1305S002R(1m) / 1405S146(5m)	RE	2015/06/22 * 12
MPA-12	MicroWave System Amplifier	Agilent	83017A	00650	RE	2015/10/01 * 12
MMM-10	DIGITAL HiTESTER	Hioki	3805	051201148	RE/CE	2016/01/18 * 12
MHF-26	High Pass Filter 3.5-18.0GHz	UL Japan	HPF SELECTOR	002	RE	2015/09/17 * 12
SAF-05	Pre Amplifier	TOYO Corporation	TPA0118-36	1440490	RE	2016/02/10 * 12
MHA-17	Horn Antenna 15-40GHz	Schwarzbeck	BBHA9170	BBHA9170307	RE	2015/06/06 * 12
MTR-10	EMI Test Receiver	Rohde & Schwarz	ESR26	101408	CE	2016/01/29 * 12
MLS-23	LISN(AMN)	Schwarzbeck	NSLK8127	8127-729	CE(EUT)	2015/07/10 * 12
MTA-53	Terminator	TME	CT-01BP	-	CE	2015/12/01 * 12
MAT-67	Attenuator	JFW Industries, Inc.	50FP-013H2 N	-	CE	2016/01/14 * 12
MCC-113	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W(10m)/SFM141(5m)/421-010 (1m)/sucoform141-P E(1m)/RFM-E121 (Switcher)	-/04178	CE	2015/07/02 * 12

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item: CE: Conducted Emission test
RE: Radiated Emission test
AT: Antenna Terminal Conducted test

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